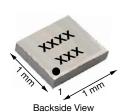
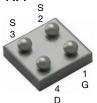


N-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω) MAX.	I _D (A) a, e	Q _g (TYP.)			
8	0.043 at $V_{GS} = 4.5 \text{ V}$	5.4				
	0.046 at V _{GS} = 2.5 V	5.2	6.8 nC			
	0.060 at V _{GS} = 1.5 V	4.6	0.6110			
	0.090 at V _{GS} = 1.2 V	3.0				

MICRO FOOT® 1 x 1





Bump Side View

Marking Code: xxxx = 8466

xxx = Date / lot traceability code

Ordering Information:

Si8466DB-T2-E1 (lead (Pb)-free and halogen-free)

FEATURES

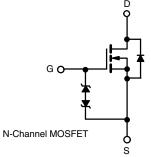
- TrenchFET® power MOSFET
- Typical ESD protection 3000 V HBM
- Ultra-Small 1 mm x 1 mm maximum outline
- Ultra-thin 0.548 mm maximum height
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

Pb-free

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- Low on-resistance load switch for portable devices
 - Low power consumption, low voltage drop
 - Increased battery life
 - Space savings on PCB



ABSOLUTE MAXIMUM RATINGS	$(T_A = 25 ^{\circ}C, unless)$	otherwise noted	d)	
PARAMETER	SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	8	V	
Gate-Source Voltage		V _{GS}	± 5	v
	T _A = 25 °C		5.4 ^a	
Continuous Drain Current (T. 150 °C)	T _A = 70 °C		4.4 ^a	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	3.6 b	
	T _A = 70 °C		2.9 b	A
Pulsed Drain Current (t = 300 μs)		I _{DM}	20	
Continuous Source-Drain Diode Current	T _C = 25 °C		1.5 ^a	
	T _A = 25 °C	Is	0.65 ^b	
	T _A = 25 °C		1.8 ^a	
Maximum Dawar Dissination	T _A = 70 °C		1.1 ^a	w
Maximum Power Dissipation	T _A = 25 °C	P _D	0.78 ^b	vv
	T _A = 70 °C		0.5 b	
Operating Junction and Storage Temperature F	T _J , T _{stg}	-55 to +150		
D 1 D 1 O 1 1 O 1	VPR		260	°C
Package Reflow Conditions ^c	IR/Convection		260	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient f, g	t = 10 s	D+	55	70	°C/W		
Maximum Junction-to-Ambient h, i	t = 10 s	Rt _{hJA}	125	160	C/VV		

Notes

- a. Surface mounted on 1" \times 1" FR4 board with full copper, t = 10 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, t = 10 s.
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. In this document, any reference to case represents the body of the MICRO FOOT device and foot is the bump.
- e. Based on $T_A = 25$ °C.
- f. Surface mounted on 1" x 1" FR4 board with full copper.
- g. Maximum under steady state conditions is 100 °C/W.
- h. Surface mounted on 1" x 1" FR4 board with minimum copper.
- i. Maximum under steady state conditions is 190 °C/W.

Document Number: 63683



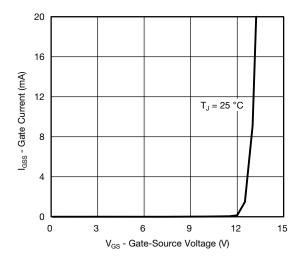
PARAMETER	SYMBOL TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static				•			
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	8	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A	-	3.5	-	\//00	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-3	-	mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	0.35	-	0.7	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$	=.	-	± 3	μΑ	
Zana Oala Vallana Baria Oanad	I _{DSS}	V _{DS} = 8 V, V _{GS} = 0 V	-	-	1	μА	
Zero Gate Voltage Drain Current		V _{DS} = 8 V, V _{GS} = 0 V, T _J = 70 °C	-	-	10		
On-State Drain Current ^a I _{D(on}		$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	10	-	-	Α	
		V _{GS} = 4.5 V, I _D = 2 A	-	0.035	0.043	Ω	
Drain-Source On-State Resistance a	В	V _{GS} = 2.5 V, I _D = 1 A	-	0.037	0.046		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 1.5 V, I _D = 1 A	-	0.045	0.060		
		$V_{GS} = 1.2 \text{ V}, I_D = 0.5 \text{ A}$	-	0.055	0.090		
Forward Transconductance a	9 _{fs}	$V_{DS} = 4 \text{ V}, I_{D} = 2 \text{ A}$	-	30	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}		-	710	-	pF	
Output Capacitance	C _{oss}	$V_{DS} = 4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	270	-		
Reverse Transfer Capacitance	C _{rss}		-	192	-		
Total Gate Charge	Qg		-	8.5	13	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 2 \text{ A}$	-	0.9	-		
Gate-Drain Charge	Q_{gd}		-	1.6	-		
Gate Resistance	Rg	V _{GS} = 0.1 V, f = 1 MHz	-	6	-	Ω	
Turn-On Delay Time	t _{d(on)}		-	10	20		
Rise Time	t _r	$V_{DD} = 4 \text{ V}, R_L = 2 \Omega$	-	15	30	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 2~A,~V_{GEN}=4.5~V,~R_g=1~\Omega$	-	40	80		
Fall Time	t _f		-	10	20		
Drain-Source Body Diode Characteris	stics			•			
Continuous Source-Drain Diode Current	Is	T _A = 25 °C	-	-	1.5	А	
Pulse Diode Forward Current	I _{SM}		_	-	20		
Body Diode Voltage	V _{SD}	$I_S = 1.5 \text{ A}, V_{GS} = 0$	-	0.7	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	30	60	ns	
Body Diode Reverse Recovery Charge Q _{rr}			-	7	15	nC	
Reverse Recovery Fall Time	ta	$I_F = 2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	15	-		
Reverse Recovery Rise Time		t _b		15	-	ns	

Notes

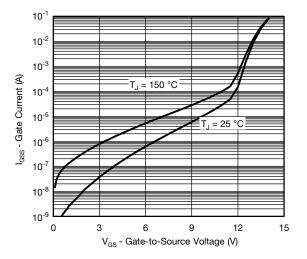
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



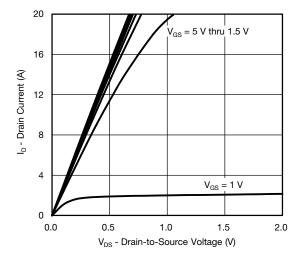


Output Characteristics

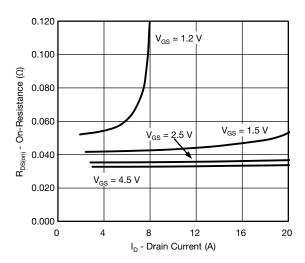


On-Resistance vs. Drain Current and Gate Voltage

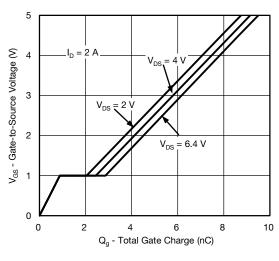




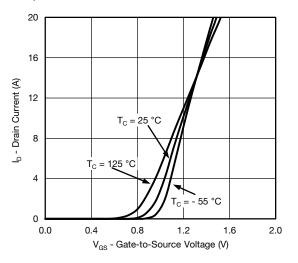
Output Characteristics



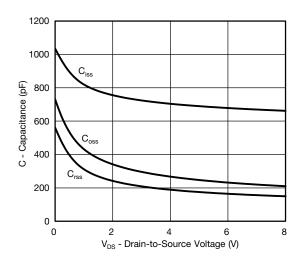
On-Resistance vs. Drain Current and Gate Voltage



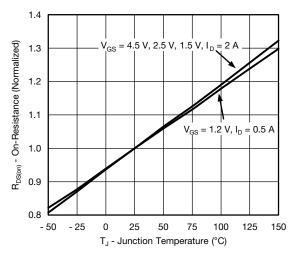
Gate Charge



Transfer Characteristics

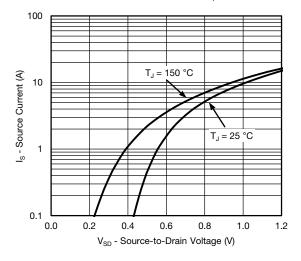


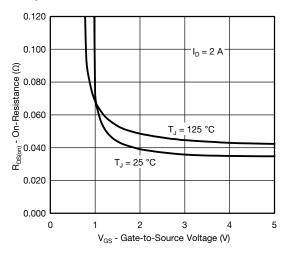
Capacitance



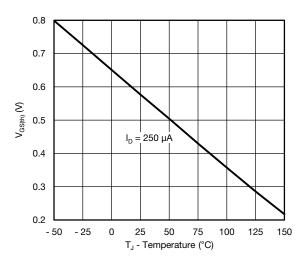
On-Resistance vs. Junction Temperature



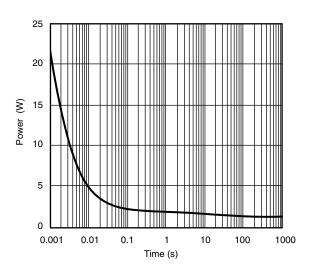




Source-Drain Diode Forward Voltage

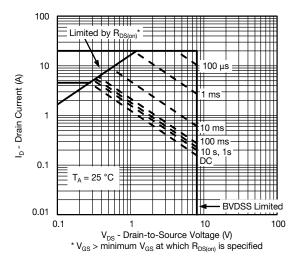


On-Resistance vs. Gate-to-Source Voltage



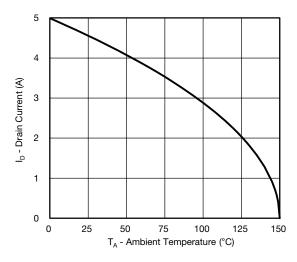
Threshold Voltage

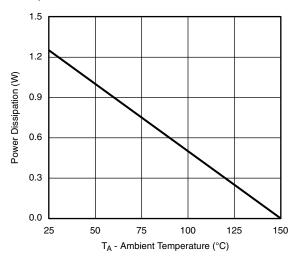
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Power Derating

Current Derating ^a

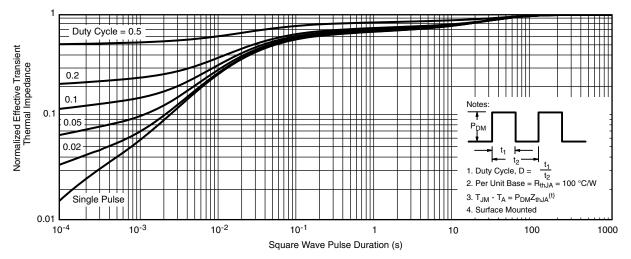
Note

• When mounted on 1" x 1" FR4 with full copper.

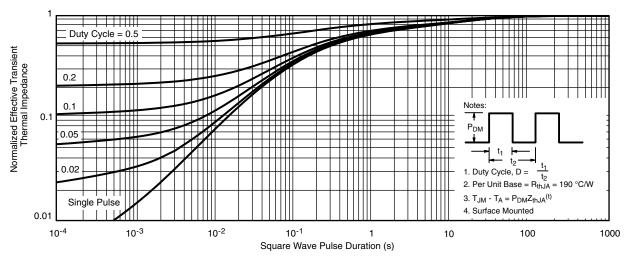
Note

a. The power dissipation P_D is based on T_J (max.) = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Full Copper)

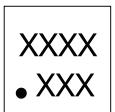


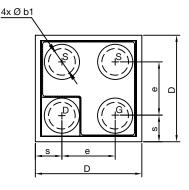
Normalized Thermal Transient Impedance, Junction-to-Ambient (1" x 1" FR4 Board with Minimum Copper)

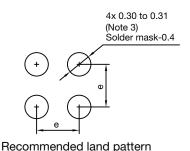
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MICRO FOOT®: 4-Bumps (1 mm x 1 mm, 0.5 mm Pitch, 0.286 mm Bump Height)

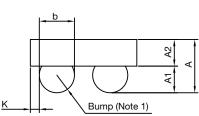
Mark on backside of die











Notes

- 1. Bumps are 95.5/3.8/0.7 Sn/Ag/Cu.
- 2. Backside surface is coated with a Ti/Ni/Ag layer.
- 3. Non-solder mask defined copper landing pad.
- 4. Laser mark on the backside surface of die.
- 5. "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- 6. is the location of pin 1

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.458	0.504	0.550	0.0180	0.0198	0.0217	
A1	0.214	0.250	0.286	0.0084	0.0098	0.0113	
A2	0.244	0.254	0.264	0.0096	0.0100	0.0104	
b	0.297	0.330	0.363	0.0117	0.0130	0.0143	
b1	0.250			0.0098			
е	0.500			0.0197			
S	0.210	0.230	0.250	0.0083	0.0091	0.0096	
D	0.920	0.960	1.000	0.0362	0.0378	0.0394	
K	0.029	0.065	0.102	0.0011	0.0026	0.0040	

Note

• Use millimeters as the primary measurement.

ECN: T15-0176-Rev. A, 27-Apr-15

DWG: 6039



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Vishay

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